


<b>Search Notes</b> 	<b>Application/Control No.</b> 10626140	<b>Applicant(s)/Patent Under Reexamination</b> FUKAGAWA ET AL.
	<b>Examiner</b> ALEX LIEW	<b>Art Unit</b> 2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
382/141-152 limited to text search	12/20/08	AL
382/141-152 limited to text search	6/10/09	AL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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